FEB 2 8 2005

THE UNITED STATES PATENT AND TRADEMARK OFFICE

Application Serial No	10/664,744
Filing Date	September 18, 2003
Inventor	Michael T. Andreas
Assignee	Micron Technology, Inc.
Group Art Unit	2823
Examiner	Fernando L. Toledo
Attorney's Docket No	
Title: Method of Polishing a Semiconductor	
Process, and Method of Cleaning Residue from	n Registration Alignment Markings

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

References - See Attached Form PTO-1449

In compliance with 37 C.F.R. §§ 1.56, 1.97 and 1.98, your attention is directed to the patents listed on the attached Form PTO-1449. No admission is made regarding whether the submitted reference is prior art.

Respectfully submitted,

Dated: 2-28-08

Mark S. Matkin Reg. No. 32,268

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Form PTO-1449		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE			ATTY. DOCKET NO. MI22-2335			SERIAL NO. 10/664,744			
LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT: Michael T. Andreas							
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*Examiner's Initials			Document Number	Date	Name		Class	Class Subclass		Filing Date If Appropriate	
	AA	6,8	35,668	12/2004	Andreas et al.	Andreas et al.		745			
	AB	6,8	35,121	12/2004	Andreas		451	41			
	AC	6,7	87,473	09/2004	Andreas		438	692			
	AD	6,6	35,562	10/2003	Andreas		438	633			
	AE	6,6	27,550	09/2003	Andreas		438	691			
	AF	6,5	89,882	07/2003	Andreas et al.		438	745			
	AG	6,4	68,951	10/2002	Grieger et al.		510	175			
	АН	6,3	75,548	04/2002	Andreas		451	41			
	AI	6,3	58,325	03/2002	Andreas		134	2			
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			Document Number	Date	Country		Class	SubclasS	clasS	Translation	
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*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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*Examiner's Initials		Document Number	Date	Name		Class	Subclass		Filing Date If Appropriate	
	AA	6,273,100	08/2001	Andreas et al.		134	1.3			
	AB	6,269,511	08/2001	Andreas et al.		15	77			
-	AC	6,265,781	07/2001	Andreas		257	765			
	AD	6,044,851	04/2000	Grieger et al.		134	1.3 .			
	AE	5,855,811	01/1999	Grieger et al.		252	79.3	79.3		
	AF	2003/0143857	07/2003	Andreas		438	710			
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